

# Search Notes



Application/Control No.

10/782,497

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under  
R examination

CHIANG ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	202	2/21/06	H2
	203	Text search using EAST	
	206		
updated above		using EAST 6/14/06	
711	207		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG	pub	Text search	
		6/14/06	H2

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	2/21/06	H2
NPL search using terms similar to EAST search	↓	↓
updated EAST search	6/14/06	H2